

<b>Notice of References Cited</b>		Application/Control No. 10/533,130	Applicant(s)/Patent Under Reexamination KAWASE ET AL.	
		Examiner Shaheda A. Abdin	Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0018032 A1	02-2002	Weitbruch et al.	345/60
*	B	US-6,388,643 B1	05-2002	Huang, Jih Fon	345/60
*	C	US-2004/0085262 A1	05-2004	Lee, Joo-Yul	345/041
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	/
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.